

ITEM P/N	TPMC0603H-SERIES	TEST INSTRUMENT	HP4284 / CH16502 Equality
PRODUCT	SMD Inductor	TEST FREQUENCY	100 kHz / 1.0V

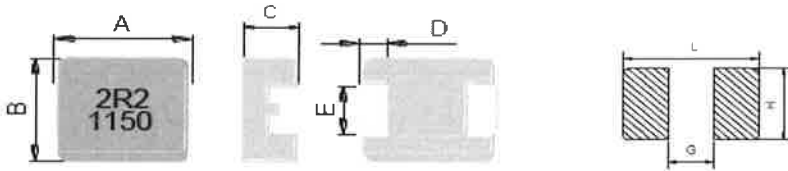
**CUSTOMER :****CUSTOMER P/N :****DESCRIPTION :** SMD INDUCTOR**SINKA P/N :** TMPC0603H-SERIES**REVISION NO. :** 00**DATE :** 2015/2/15**NOTES :** STANDARD

DOCUMENTED BY	
APPROVED	Y Imai
CHECKED	Cosby Liu
PREPARED	Wenny Wei

**CUSTOMER APPROVAL**

company seals

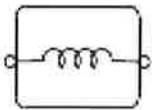
ITEM P/N	TMPC0603-SERIES	TEST INSTRUMENT	HP4284 / CH16502 Equality
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**PACKING DIMENSIONS (mm)**

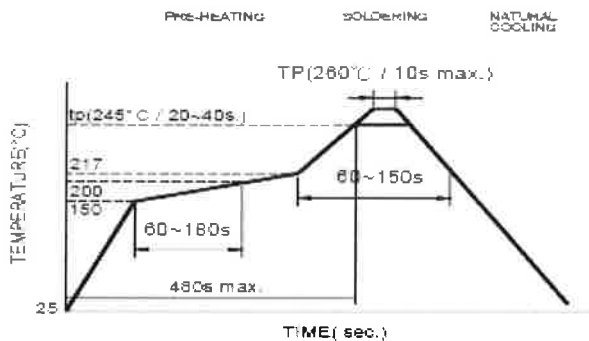
TMPC 0603	Dimensions
A	7.3 ± 0.3
B	6.6 ± 0.3
C	2.8 ± 0.2
D	1.8 ± 0.3
E	3.0 ± 0.3
L	8.4 Typ
G	2.5 Typ
H	3.5 Typ

**EXPLANATION OF PART NUMBERS**

1	2	3	4	5	6	7	8	9	10	11	12	
T	M	P	C	0	6	0	3H	-	R	4	7	M
<b>Serial Codes</b>				<b>Size</b>			<b>Inductance Code</b>					

**CONNECTIONS**

- ⊙ Inductor Contents ONE (1) Set(s) of Coil
- ⊙ DC/AC Current Shall Be Introduced By Any One of Two Pads

**RECOMMENDED SOLDERING TEMP. GRAPH**

Reflow times: 3 times max.

**Manual Soldering for rework**

Solder Iron Temperature : 350 °Cmax  
 Soldering Times : Less than 5sec  
 ( Manual Soldering is 1 time only )

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**ELECTRICAL CHARACTERISTICS**

P/N	L0 Inductance $\mu\text{H} \pm 20\%$ @0A	DCR (m $\Omega$ )		Heat Rating Current Idc (AMP) Typical	Saturation Current Isat (AMP) Typical
		[Typical]	[ Max ]		
TMPC0603H-R22YG-D	0.22 $\pm$ 30%	2.1	2.8	23.0	40.0
TMPC0603H-R33MG-D	0.33	3.5	3.9	20.0	32.0
TMPC0603H-R47MG-D	0.47	4.0	4.2	17.5	26.0
TMPC0603H-R56MG-D	0.56	4.7	5.0	16.5	25.5
TMPC0603H-R68MG-D	0.68	4.8	5.5	15.5	25.0
TMPC0603H-R75MG-D	0.75	5.5	6.6	14.5	24.5
TMPC0603H-R82MG-D	0.82	6.7	8.0	13.0	24.0
TMPC0603H-1R0MG-D	1.00	8.3	10	11.0	22.0
TMPC0603H-1R5MG-D	1.50	13	15	9.0	18.0
TMPC0603H-1R8MG-D	1.80	14	17	8.5	16.0
TMPC0603H-2R2MG-D	2.20	18	20	8.0	14.0
TMPC0603H-2R5MG-D	2.50	20	22	7.0	13.0
TMPC0603H-3R3MG-D	3.30	28	30	6.0	13.5
TMPC0603H-4R7MG-D	4.70	37	40	5.5	10.0
TMPC0603H-5R6MG-D	5.60	43	48	5.0	9.0
TMPC0603H-6R8MG-D	6.80	54	60	4.5	8.0
TMPC0603H-8R2MG-D	8.20	64	68	4.0	7.5
TMPC0603H-100MG-D	10.0	75	85	3.5	6.0
TMPC0603H-220MG-D	22.0	165	190	2.0	3.5

- ⊙ All test Data is referenced to 25°C ambient
- ⊙ Typical Heat Rating DC Current would cause an approximately  $\Delta T$  of 40°C
- ⊙ Typical Saturation DC Current would cause L<sub>0</sub> to drop approximately 20%
- ⊙ The Part temperature (ambient +  $\Delta T$ ) should not exceed 125°C under worst case operating conditions.
- ⊙ Circuit design, component placement, PWB trace size and thickness, airflow and other cooling provisions all effect the part temperature. Part temperature should be verified in the end application.

**Storage Condition**

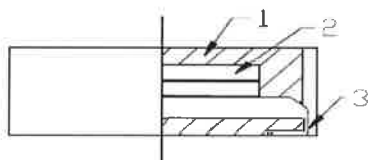
Temperature : 0 ~ 40°C

Humidity : 20~65%RH

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**Marking**

Marking showed inductance value  
 2R2 = Inductance ( 2.2uH)  
 1150 = Date Code  
 11 = Years ( 2011 )  
 50 = Weeks

**Structure**

NO	Items	Materials
1	Core	Carbonyl powder or equ.
2	Wire	Polyester Wire or equivalent.
3	Solder Plating	100% Pb free solder

**Break Down Ratio**

This value is calculate based on MIL-HDBK-217F

Calculated Formuta  $\lambda p = \lambda b \times \pi c \times \pi Q \times \pi E$

$\lambda p$  = Supposition of break down ratio       $\lambda b$  = Based break down ratio

$\pi c$  = Based on Structure

$\pi Q$  = Quality Factor

$\pi E$  = Environment Factor

**Result**

$\lambda p = 0.00096$  [pcs/10 h] = 76.8 [pcs/10 h] = 77 FIT

**Calcurate Condition**

Max motion temperature TCM = 105°C ( General Supposition )

Temperature Rising  $\Delta T = 35K$  ( When flow the rated current )

Max Surroundings Temperature TAM = 50°C ( General Supposition )

Hot Spot Temperature THS = 85°C (  $\Delta T + T_A$  )

→ Based break down ratio  $\lambda b = 0.00096$  [ pcs/10 h ] ( TCM , THS , MIL-HDBK-217F )

→ Based on Structure  $\pi c = 1.0$  Fix Inductor ( MIL-HDBK-217F )

→ Quality Factor  $\pi Q = 20$  for public application ( MIL-HDBK-217F )

→ Environmental Factor  $\pi E = 4.0$  GB grade ( MIL-HDBK-217F )

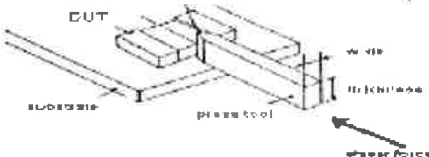
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## Reliability and Test Condition

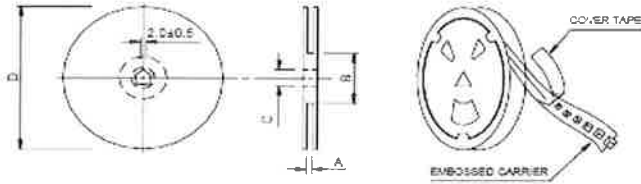
Item	Performance	Test Method and Remarks															
Operating Temperature	-40~+125 (C)																
Storage Temperature	-40~+125 (C)(on board)																
Rated current	Within the specified tolerance																
Inductance (L)		LCR Meter: HP 4285A or equivalent, 100kHz, 1V															
DC Resistance		DC Ohmmeter: H2693227 or equivalent															
Life Test		Preconditioning: Reflow through IR reflow for 2 times; (IPC/JEDEC J-STD-020D0 classification Reflow Profile) Temperature: +125±2° (Board) Temperature: +85±2° (Inductor) Applied current: rated current Duration: 1000±10hrs Measured at room temperature after pacing for 24±2 hrs															
Load Humidity	Preconditioning: Reflow through IR reflow for 2 times; (IPC/JEDEC J-STD-020D0 classification Reflow Profile) Humidity: 85±2% R.H. Temperature: 85°±2° Duration: 1000hrs/4hrs with 100% rated current Measured at room temperature after pacing for 24±2 hrs																
Thermal shock	Appearance: No Damage Inductance: within ±10% of initial value CR: Shall not exceed the specification value RDC: within ±15% of initial value and shall not exceed the specification value	Preconditioning: Reflow through IR reflow for 2 times; (IPC/JEDEC J-STD-020D0 classification Reflow Profile) Condition for 1 cycle Step1: -40±2°; 30±5min Step2: 25±2°; 1±0.5min Step3: 105±2°; 30±5min Number of cycles: 500 Measured at room temperature after pacing for 24±2 hrs															
Vibration		Excitation Frequency: 10 ~ 2K ~ 10KHz for 20 minutes Equipment: Vibration shaker Tune Amplitude: 1.52mm±10% Testing Time: 12 hours(20 minutes: 12 cycles each of 3 accelerations)															
Shock		<table border="1"> <thead> <tr> <th>type</th> <th>Peak Value (g)</th> <th>Normal Duration (s)</th> <th>Wave form</th> <th>Velocity Change (M/Phase)</th> </tr> </thead> <tbody> <tr> <td>SMD</td> <td>1500</td> <td>0.5</td> <td>Half Sine</td> <td>15.4</td> </tr> <tr> <td>Lead</td> <td>100</td> <td>8</td> <td>Half Sine</td> <td>12.8</td> </tr> </tbody> </table>	type	Peak Value (g)	Normal Duration (s)	Wave form	Velocity Change (M/Phase)	SMD	1500	0.5	Half Sine	15.4	Lead	100	8	Half Sine	12.8
type	Peak Value (g)	Normal Duration (s)	Wave form	Velocity Change (M/Phase)													
SMD	1500	0.5	Half Sine	15.4													
Lead	100	8	Half Sine	12.8													
Bending		Shall be mounted on a FR4 substrate of the following dimensions: ~0805, 40x100x1.2mm ~0805, 40x100x0.8mm Bending depth: ~0805, 1.2mm ~0805, 0.8mm Duration of 10 sec															

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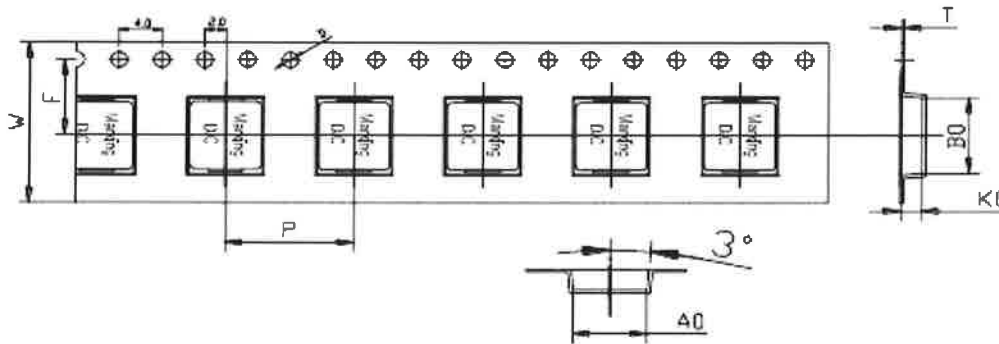
## Reliability and Test Condition -2

Item	Performance	Test Method and Remarks						
Solderability	More than 95% of the terminal electrode should be covered with solder.	Preheat: 150°C, 50sec. Solder: Sn99.5%–Cu0.5% Temperature: 245±5°C Flux for lead free: Rosin: 9.5% Dip time: 4±1sec. Depth: completely cover the termination						
Resistance to Soldering Heat		Number of heat cycles: 1 <table border="1"> <thead> <tr> <th>Temperature (°C)</th> <th>Time(s)</th> <th>Temperature ramp/immersion and emersion rate</th> </tr> </thead> <tbody> <tr> <td>260 ±5; solder temp.)</td> <td>10 ±1</td> <td>25mm/s ±6 mm/s</td> </tr> </tbody> </table>	Temperature (°C)	Time(s)	Temperature ramp/immersion and emersion rate	260 ±5; solder temp.)	10 ±1	25mm/s ±6 mm/s
Temperature (°C)	Time(s)	Temperature ramp/immersion and emersion rate						
260 ±5; solder temp.)	10 ±1	25mm/s ±6 mm/s						
Terminal Strength	Appearance : No damage. Inductance : within ±10% of initial value Q : Shall not exceed the specification value. RDC : within ±15% of initial value and shall not exceed the specification value	Preconditioning: Run through R reflow for 3 times. (IPC/JEDEC J-STD-020D) Classification Reflow Profiles With the component mounted on a PCB with the device to be tested, apply a force (±300: 1kg, ±3800: 0.5kg) to the side of a device being tested. This force shall be applied for 50 – 1 seconds. Also the force shall be applied gradually so not to apply a shock to the component being tested. 						

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**PACKING INFORMATION****(1) Reel Dimension**

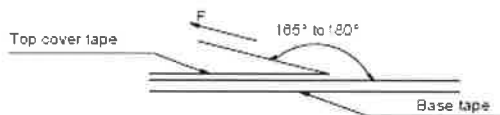
Size	Type	A(mm)	B(mm)	C(mm)	D(mm)
0302 0412/02 0512/15/18/20/30	13"x12mm	12.0±0.5	100±2	13.5±0.5	330
053T 0612/15/18/02/24/03/05	10"x18mm	15.0±0.5	100±2	13.5±0.5	330

**(2) Tape Dimension**

Series	Size	Bo(mm)	Ao(mm)	Ko(mm)	P(mm)	W(mm)	F(mm)	t(mm)	D(mm)
TMPC	0603	7.8±0.1	7.1±0.1	3.3±0.1	12.0±0.1	16.0±0.3	7.5±0.1	0.35±0.05	1.5±0.1

**(3) Packaging Quantity**

TMPC	0302	0412	0402	0512	0515	0518/02	053T	0503	0612	0615/18	0602/24	0603	0605
Chip / Reel	3000	4000	3000	4000	3500	3000	1000	2000	3000	2000	1500	1000	800
Inner box	6000	8000	6000	8000	7000	6000	2000	4000	6000	4000	3000	2000	1600
Carton	24000	32000	24000	32000	28000	24000	8000	16000	24000	16000	12000	8000	6400

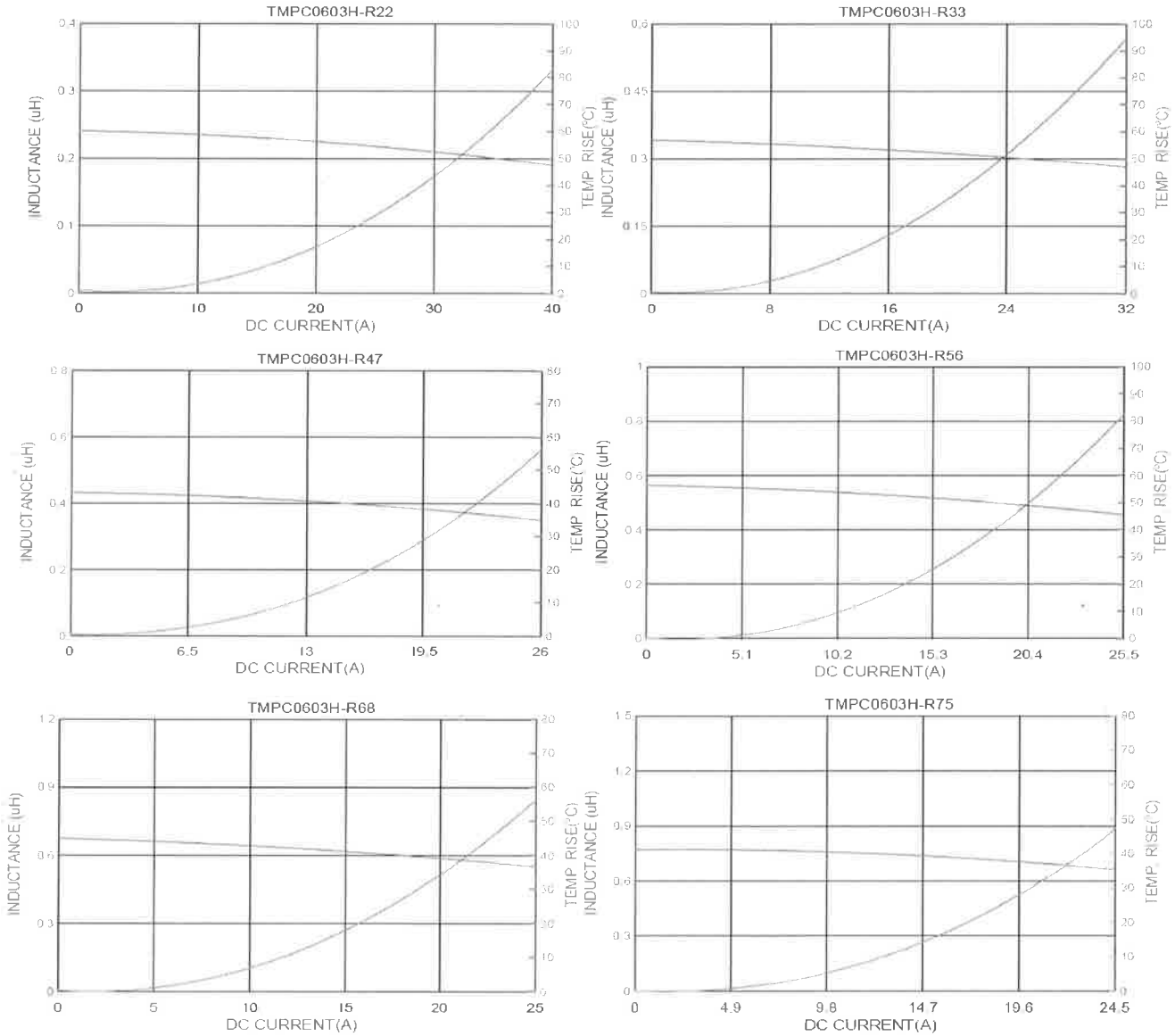
**(4) Tearing Off Force**

The force for tearing off cover tape is 10 to 130 grams in the arrow direction under the following conditions (referenced ANSI/EIA-481-C-2003 of 4.11 standard).

Room Temp. (°C)	Room Humidity (%)	Room atm (hPa)	Tearing Speed mm/min
5~35	45~85	860~1060	300

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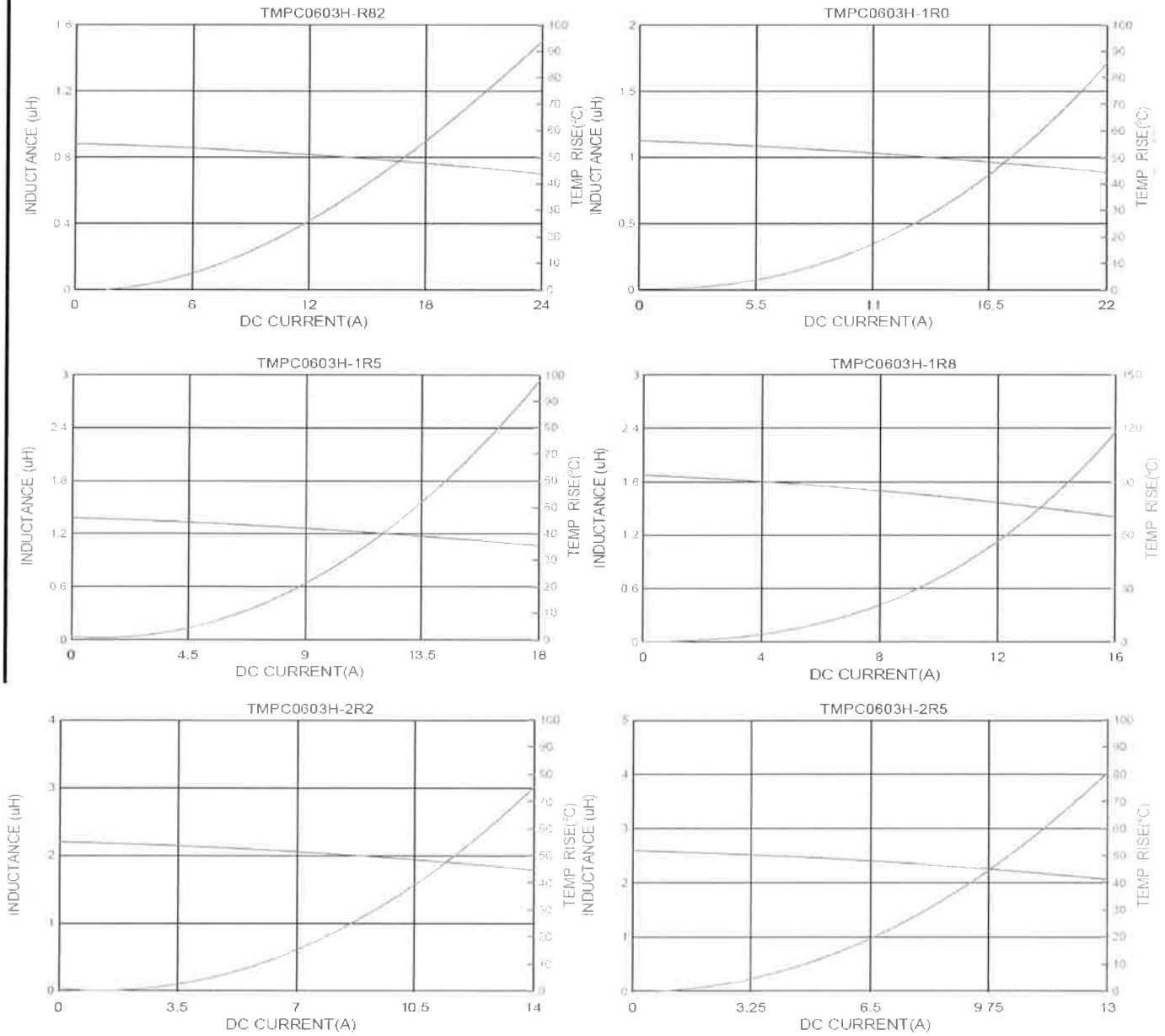
## DC-Bias Characterization





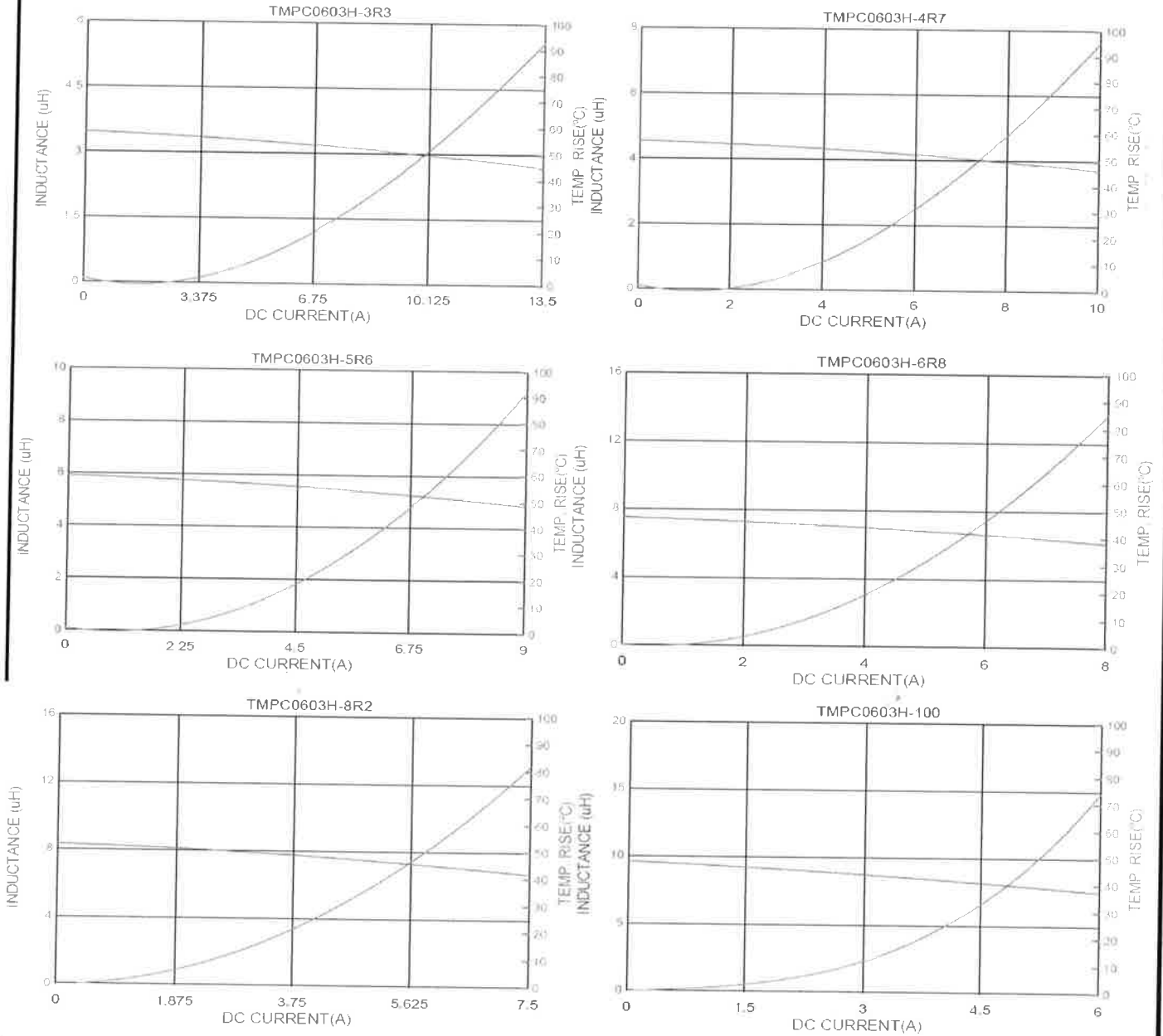
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